MOSFET - Power, Single N-Channel 60 V, 0.68 mΩ, 477 A

Features

- Small Footprint (8x8 mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Q_G and Capacitance to Minimize Driver Losses
- Power 88 Package, Industry Standard
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V_{DSS}	60	٧
Gate-to-Source Voltage			V _{GS}	±20	V
Continuous Drain	Steady	T _C = 25°C	I _D	477	Α
Current R _{θJC} (Notes 1, 3)		T _C = 100°C		337.6	
Power Dissipation	State	T _C = 25°C	P_{D}	294.6	W
R _{θJC} (Note 1)		T _C = 100°C		147.3	
Continuous Drain	T _A = 25°C		I _D	62.2	Α
Current R _{0JA} (Notes 1, 2, 3)	Steady	T _A = 100°C		44.0	
Power Dissipation	State	T _A = 25°C	P_{D}	5.0	W
R _{θJA} (Notes 1, 2)		T _A = 100°C		2.5	
Pulsed Drain Current	T _A = 25	°C, t _p = 10 μs	I _{DM}	900	Α
Operating Junction and Storage Temperature Range			T _J , T _{stg}	-55 to +175	°C
Source Current (Body Diode)			Is	245.5	Α
Single Pulse Drain-to-Source Avalanche Energy (I _{L(pk)} = 40 A)			E _{AS}	1754	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State	$R_{\theta JC}$	0.5	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	30	

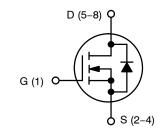
- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.
- 3. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.



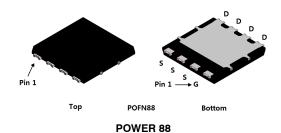
ON Semiconductor®

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V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX	
60 V	0.68 m Ω @ 10 V	477 A	
00 V	$0.90~\mathrm{m}\Omega$ @ $4.5~\mathrm{V}$		



N-CHANNEL MOSFET



MARKING DIAGRAM

CASE 507AP



XXX = Device Code

(8 A-N characters max)

A = Assembly Location

WL = 2-digit Wafer Lot Code

Y = Year Code

WW = Work Week Code

ORDERING INFORMATION

See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit	
OFF CHARACTERISTICS	-							
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0 V, I _D = 250 μA		60			V	
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /	I _D = 250 μA. ref to 25°C			16.8		mV/°C	
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 V$,	T _J = 25°C			10		
		V _{DS} = 60 V	T _J = 125°C			250	μΑ	
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS} = 20 V				100	nA	
ON CHARACTERISTICS (Note 4)	•				•		•	
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = 250 \mu A$		1.0		2.5	٧	
Threshold Temperature Coefficient	V _{GS(TH)} /T _J	I _D = 250 μA. ref to 25°C			-5.63		mV/°C	
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 50 A		0.52	0.68	mΩ	
		V _{GS} = 4.5 V	I _D = 50 A		0.69	0.90		
Forward Transconductance	9FS	V _{DS} =15 V, I _D = 50 A			310		S	
CHARGES, CAPACITANCES & GATE RE	SISTANCE						•	
Input Capacitance	C _{ISS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 25 V			16200		pF	
Output Capacitance	C _{OSS}				8490			
Reverse Transfer Capacitance	C _{RSS}				270			
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 4.5 V, V _{DS} = 30 V; I _D = 50 A			103			
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 30 V; I _D = 50 A			225			
Threshold Gate Charge	Q _{G(TH)}	V _{GS} = 10 V, V _{DS} = 30 V; I _D = 50 A			21.6		nC	
Gate-to-Source Charge	Q _{GS}				36.5			
Gate-to-Drain Charge	Q_GD				20.7			
Plateau Voltage	V_{GP}				2.46		٧	
SWITCHING CHARACTERISTICS (Note &	5)						•	
Turn-On Delay Time	t _{d(ON)}				35.3			
Rise Time	t _r	V _{GS} = 10 V, V _{DS}	s = 30 V.		26.3			
Turn-Off Delay Time	t _{d(OFF)}	$I_D = 50 \text{ A}, R_G = 6 \Omega$			263		- ns	
Fall Time	t _f				60.7			
DRAIN-SOURCE DIODE CHARACTERIS	TICS				•			
Forward Diode Voltage	V_{SD}	V _{GS} = 0 V, I _S = 50 A	T _J = 25°C		0.67	1.2		
			T _J = 125°C		0.59			
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 \text{ V, dIS/dt} = 100 \text{ A/}\mu\text{s,}$ $I_{S} = 50 \text{ A}$			115		ns	
Charge Time	t _a				70			
Discharge Time	t _b				45			
Reverse Recovery Charge	Q _{RR}				307		nC	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Pulse Test: pulse width $\leq 300~\mu s$, duty cycle $\leq 2\%$.

5. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS

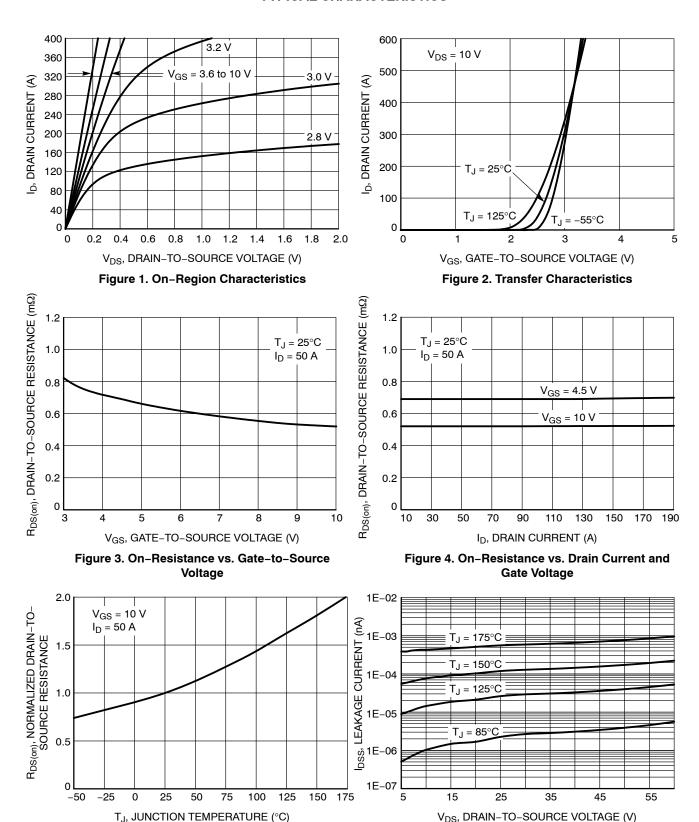


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS

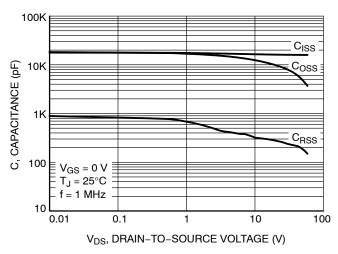


Figure 7. Capacitance Variation

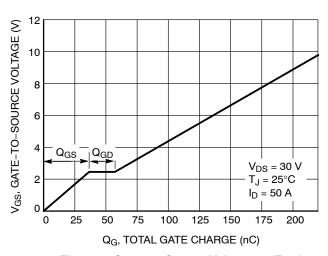


Figure 8. Gate-to-Source Voltage vs. Total Charge

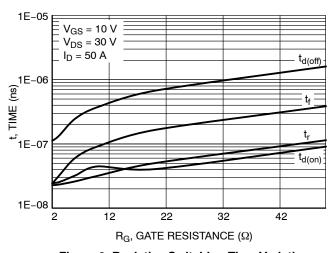


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

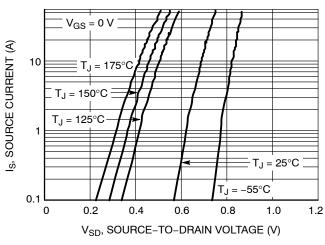


Figure 10. Diode Forward Voltage vs. Current

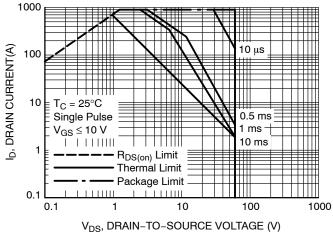


Figure 11. Maximum Rated Forward Biased Safe Operating Area

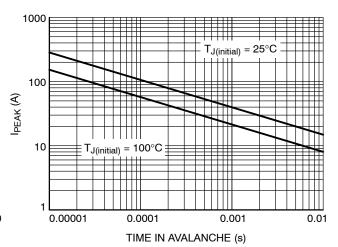


Figure 12. Maximum Drain Current vs. Time in Avalanche

TYPICAL CHARACTERISTICS

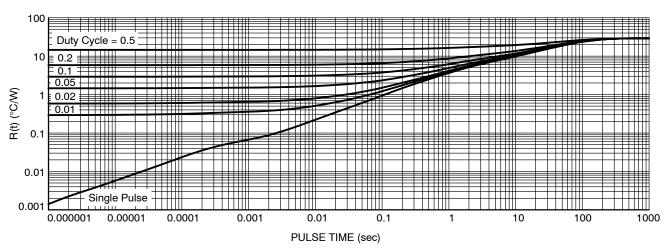


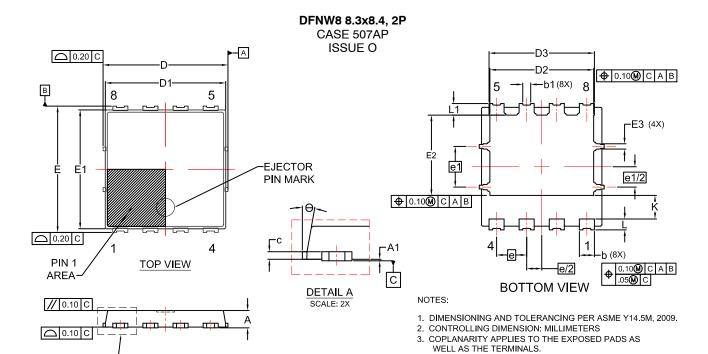
Figure 13. Thermal Characteristics

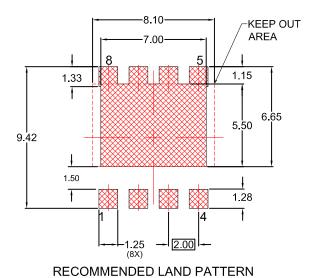
DEVICE ORDERING INFORMATION

Device	Marking	Package	Shipping [†]
NTMTS0D7N06CLTXG	0D7N06CL	POWER 88 (Pb-Free)	3000 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS





FRONT VIEW

SEE DETAIL A

MILLIMETERS DIM MIN. NOM. MAX. 1.00 1.20 Α 1.10 Α1 0.00 0.05 b 0.90 1.00 1.10 0.43 0.53 0.63 b1 0.23 0.28 0.33 D 8.20 8.30 8.40 D1 7.90 8.00 8.10 D2 6.80 6.90 7.00 6.90 D3 7.00 7.10 8.30 8.40 8.50 E1 7.80 7.90 8.00 E2 5.24 5.34 5.44 0.35 0.45 E3 0.25 е 2.00 BSC e/2 1.00 BSC 2.70 BSC e1 e1/2 1.35 BSC 1.57 1.70 Κ 1.50 0.64 0.74 0.84 0.87 L1 0.67 0.77 0° 12° θ

DIMENSIONS D1 AND E1 DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.

"A1" IS DEFINED AS THE DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT ON THE PACKAGE BODY.

5. SEATING PLANE IS DEFINED BY THE TERMINALS.

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